Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/735,979	KIM, HAK-SOO	
Examiner	Art Unit	
CongVan Tran	2683	

SEARCHED				
Class	Subclass	Date	Examiner	
455	456.1 404.1 404.2* 407 456.2* 414.2	9/30/2005	ст	
	457			
342	350 357.01	9/30/2005	ст	
	357.06*			
	357.07*			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
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